

**Search Notes**

Application/Control No.

10/538,241

Examiner

Ibrahim A. Khan

Applicant(s)/Patent under  
Reexamination

VENDEL ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
370	329	12/7/2006	IAK
370	389	12/7/2006	IAK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASTImage and keyword search in USPAT, US-PGPUB, DERWENT, EPO, IBM_TDB (see attached search strategy)	12/7/2006	IAK